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International Conference on Technology and Instrumentation in Particle Physics 2017(TIPP2017)

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R4-Semiconductor detectors(6) - Room 307 (14:00-15:30)

- Conveners: Arai, Yasuo; Gan, K.K.

time	title	presenter
14:00	An SOI pixel sensor with in-pixel binary counters	LU, Yunpeng
14:18	Fine-Pixel Detector FPIX Realizing Sub-micron Spatial Resolution Developed Based on FD-SOI Technology	HARA, Kazuhiko
14:36	A monolithic pixel sensor with fine space-time resolution based on Silicon-on-Insulator technology for the ILC vertex detector	ONO, Shun
14:54	Secondary electron yield of nano-thick aluminum oxide and its application on MCP detector	BAOJUN, Yan
15:12	Signal to noise ratio of Low Gain Avalanche Detector	YAN, Guangqing